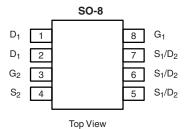


## Dual N-Channel 30-V (D-S) MOSFET with Schottky Diode

PRODUCT SUMMARY						
	$V_{DS}(V)$	$R_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)		
Channel-1	30	0.021 at $V_{GS} = 10 \text{ V}$	8.4	6.7		
		0.027 at $V_{GS} = 4.5 \text{ V}$	7.4	0.7		
Channel-2		0.020 at $V_{GS} = 10 \text{ V}$	8 <sup>d</sup>	7.0		
		$0.025$ at $V_{GS} = 4.5 \text{ V}$	8 <sup>d</sup>	7.0		

SCHOTTKY PRODUCT SUMMARY					
V <sub>DS</sub> (V)	V <sub>SD</sub> (V) Diode Forward Voltage	I <sub>F</sub> (A)			
30	0.50 V at 1.0 A	2.0			



Ordering Information: Si4914BDY-T1-E3 (Lead (Pb)-free)

Si4914BDY-T1-GE3 (Lead (Pb)-free and Halogen-free)

#### **FEATURES**

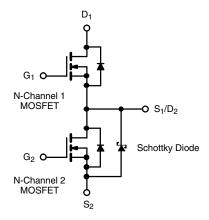
- Halogen-free According to IEC 61249-2-21 **Definition**
- LITTLE FOOT  $^{\otimes}$  Plus Integrated Schottky 100  $^{\otimes}$  Rg and UIS Tested
- Compliant to RoHS Directive 2002/95/EC



COMPLIANT HALOGEN **FREE** 

#### **APPLICATIONS**

- Notebook PC
  - System Power dc-to-dc



Parameter	Symbol	Channel-1	Channel-2	Unit	
Drain-Source Voltage	V <sub>DS</sub>	30		V	
Gate-Source Voltage	$V_{GS}$	2			
	T <sub>C</sub> = 25 °C		8.4	8 <sup>d</sup>	
Outine Dai: Out /T 450 00/8 h	T <sub>C</sub> = 70 °C		6.7	7.4	İ
Continuous Drain Current (T <sub>J</sub> = 150 °C) <sup>a, b</sup>	T <sub>A</sub> = 25 °C	I <sub>D</sub>	6.7 <sup>b, c</sup>	7.4 <sup>b, c</sup>	Í
	T <sub>A</sub> = 70 °C		5.3 <sup>b, c</sup>	5.7 <sup>b, c</sup>	Í
Pulsed Drain Current (10 μs Pulse Width)		I <sub>DM</sub>	40	40	Α
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	- I <sub>S</sub>	2.4	2.8	Í
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C		1.0 <sup>b, c</sup>	1.1 <sup>b, c</sup>	İ
PulseD Source-Drain Current		I <sub>SM</sub>	40	40	İ
Single-Pulse Avalanche Current	0.1 m	I <sub>AS</sub>	15		
Single-Pulse Avalanche Energy	L = 0.1 mH		11.2		mJ
	T <sub>C</sub> = 25 °C	- P <sub>D</sub>	2.7	3.1	
	T <sub>C</sub> = 70 °C		1.7	2.0	147
Maximum Power Dissipation <sup>a, b</sup>	T <sub>A</sub> = 25 °C		1.7 <sup>b, c</sup>	2.0 <sup>b, c</sup>	W
	T <sub>A</sub> = 70 °C		1.1 <sup>b, c</sup>	1.2 <sup>b, c</sup>	Í
Operating Junction and Storage Temperature Rar	T <sub>J</sub> , T <sub>stg</sub>	- 55	to 150	°C	

- a. Based on  $T_C$  = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Package limited.

Document Number: 69654 S09-2109-Rev. E, 12-Oct-09



THERMAL RESISTANCE RATINGS									
		Chan	nel-1	Chan	nel-2				
Parameter	Symbol	Тур.	Max.	Тур.	Max.	Unit			
Maximum Junction-to-Ambient <sup>a</sup>	t ≤ 10 s	$R_{thJA}$	59	70	52	62.5	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	36	45	32	40	C/VV		

#### Notes:

b. Maximum under Steady State conditions is 120 °C/W for Channel 1 and 115 °C/W for Channel 2.

MOSFET SPECIFICATION	<b>IS</b> T <sub>J</sub> = 25	°C, unless otherwise noted					
Parameter	Symbol	Test Conditions	Min.	Typ. <sup>a</sup>	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	$V_{DS}$	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	Ch-1	30			- V
	20	. d3	Ch-2	30			
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA	Ch-1		35		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	.D	Ch-1		- 6.2		
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	Ch-1	1.2		2.7	V
	- G3(III)	- 103 - 103, 10 - 10   11	Ch-2	1.2		2.7	
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = 20 \text{ V}$	Ch-1			100	nA
		23 - 7 d3 -	Ch-2			100	
		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$	Ch-1 Ch-2			100	- - μΑ
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 85 °C	Ch-1			100 15	
			Ch-2			10000	
	I <sub>D(on)</sub>	V <sub>DS</sub> = 5 V, V <sub>GS</sub> = 10 V	Ch-1	20		10000	Α
On-State Drain Current <sup>b</sup>			Ch-2	20			
		$V_{GS} = 10 \text{ V}, I_{D} = 8 \text{ A}$	Ch-1		0.0165	0.021	
	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 8 A	Ch-2		0.0155	0.020	=
Drain-Source On-State Resistance <sup>b</sup>		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 6 A	Ch-1		0.0215	0.027	Ω
		$V_{GS} = 4.5 \text{ V, I}_{D} = 6 \text{ A}$	Ch-2		0.020	0.025	
		$V_{DS} = 15 \text{ V}, I_{D} = 8 \text{ A}$	Ch-1		29		
Forward Transconductance <sup>b</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 8 A Ch-2			33		S
		I <sub>S</sub> = 1.7 A, V <sub>GS</sub> = 0 V	Ch-1		0.77	1.1	
Diode Forward Voltage <sup>b</sup>	$V_{SD}$	I <sub>S</sub> = 1 A, V <sub>GS</sub> = 0 V	Ch-2		0.46	0.5	V
Dynamic <sup>a</sup>			0.1.2		0.10	0.0	
Dynamic			Ch-1		6.7	10.5	1
Total Gate Charge	$Q_g$	Channel-1	Ch-2		7.0	11.0	
	_	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 8 \text{ A}$	Ch-1		2.8		
Gate-Source Charge	$Q_{gs}$	Channel-2	Ch-2		2.8		nC
Cata Duain Obanna	Q <sub>gd</sub>	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 8 A	Ch-1		2.0		1
Gate-Drain Charge		20 - 7 00 112 13 10 071	Ch-2		2.0		1
Gate Resistance	- D		Ch-1		2.9	6.0	Ω
Gate Hesistance	R <sub>g</sub>		Ch-2		2.0	4.0	22

a. Surface Mounted on 1" x 1" FR4 board.



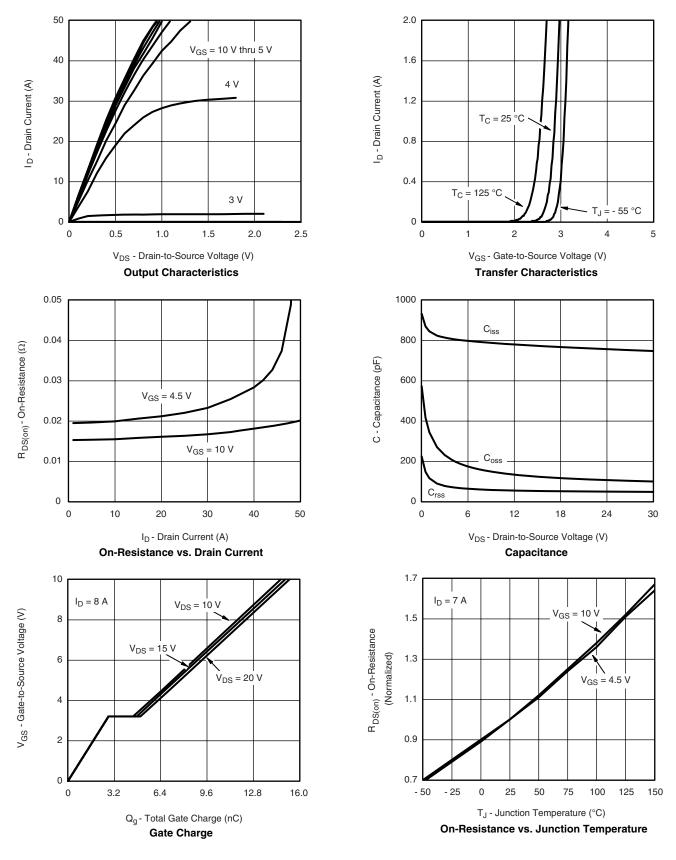
MOSFET SPECIFICATIONS T <sub>J</sub> = 25 °C, unless otherwise noted							
Parameter	Symbol	Test Conditions	Min.	Typ. <sup>a</sup>	Max.	Unit	
Dynamic <sup>a</sup>							
Turn-On Delay Time	t. <sub>1</sub> /		Ch-1		9	18	
Turr-On Delay Time	t <sub>d(on)</sub>	Channel-1	Ch-2		10	20	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 3 $\Omega$ $I_D \cong$ 5 A, $V_{GEN}$ = 10 V, $R_\alpha$ = 1 $\Omega$	Ch-1		10	20	
Tilse Tillle	r	$I_D = 5 \text{ A}, V_{GEN} = 10 \text{ V}, H_g = 1 \Omega$	Ch-2		9	18	
Turn-Off Delay Time	t <sub>d(off)</sub>	Channel-2	Ch-1		16	32	]
Turr-On Delay Time		$V_{DD} = 15 \text{ V}, R_L = 3 \Omega$	Ch-2		16	32	ns
Fall Time	t <sub>f</sub>	$I_D \cong 5 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	Ch-1		9	18	
Tall Tillie			Ch-2		8	16	
Source Drain Boyeres Becovery Time	t <sub>rr</sub>	$I_F = 2.2 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}$	Ch-1		35	55	
Source-Drain Reverse Recovery Time		I <sub>F</sub> = 2.2 A, dI/dt = 100 A/μs	Ch-2		21	35	
Redu Riede Reverse Reserver Charge	Q <sub>rr</sub>	I <sub>F</sub> = 2.2 A, dI/dt = 100 A/μs	Ch-1		40		0
Body Diode Reverse Recovery Charge		I <sub>F</sub> = 2.2 A, dI/dt = 100 A/μs	Ch-2		11		nC
Barrera Barrera Fall Time	t <sub>a</sub>	I <sub>F</sub> = 2.2 A, dI/dt = 100 A/μs	Ch-1		19		
Reverse Recovery Fall Time		I <sub>F</sub> = 2.2 A, dl/dt = 100 A/μs	Ch-2		11		
Barrier Branch Birth Time	t <sub>b</sub>	I <sub>F</sub> = 2.2 A, dl/dt = 100 A/μs	Ch-1		16		ns
Reverse Recovery Rise Time		I <sub>F</sub> = 2.2 A, dl/dt = 100 A/μs	Ch-2		10		

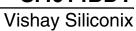
- a. Guaranteed by design, not subject to production testing. b. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## VISHAY.

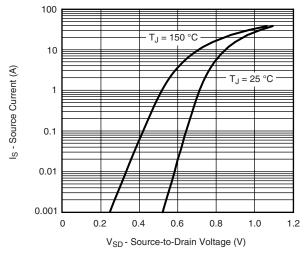
#### CHANNEL-1 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



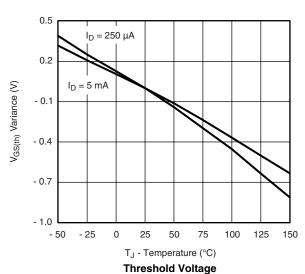


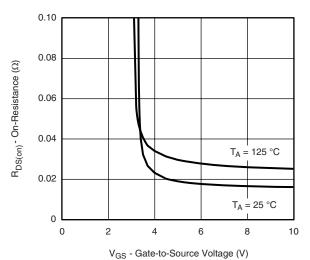


#### CHANNEL-1 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

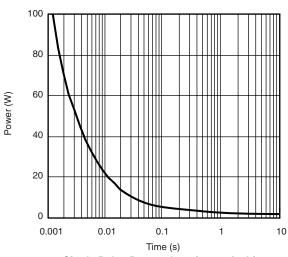


#### Source-Drain Diode Forward Voltage

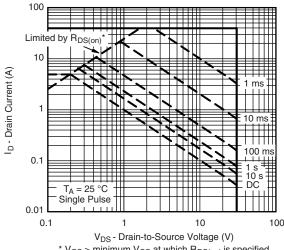




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

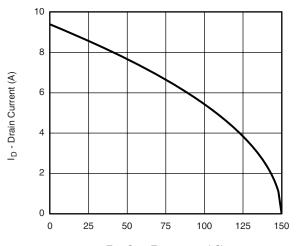


 $^{\star}$   $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area

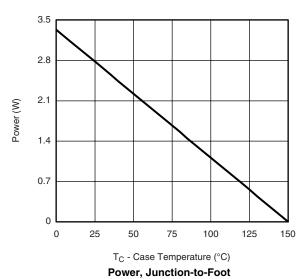
## VISHAY.

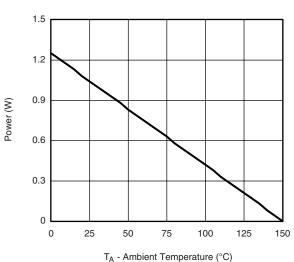
#### CHANNEL-1 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



T<sub>C</sub> - Case Temperature (°C)

#### **Current Derating\***





Power, Junction-to-Ambient

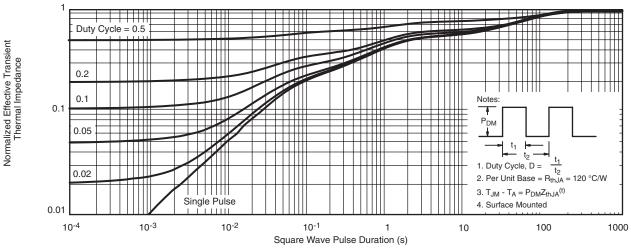
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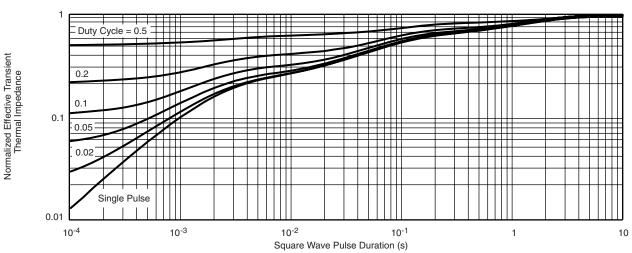
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



#### CHANNEL-1 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



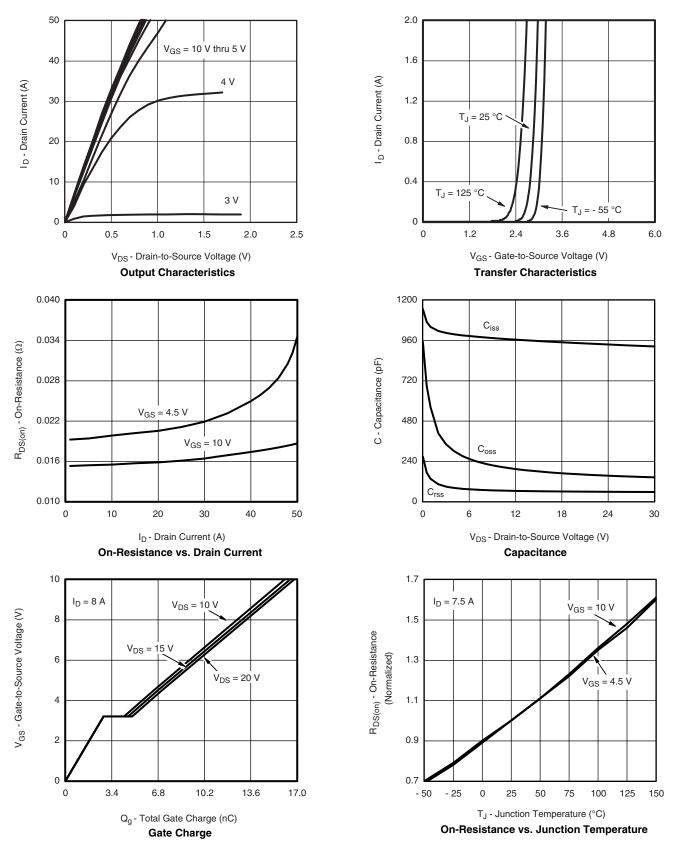
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

## VISHAY

#### CHANNEL-2 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

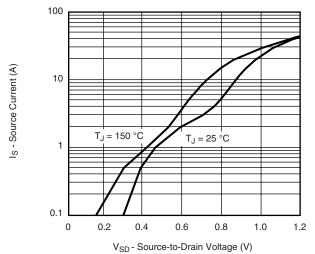


8

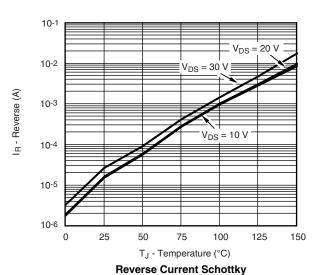
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#### CHANNEL-2 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



#### Source-Drain Diode Forward Voltage

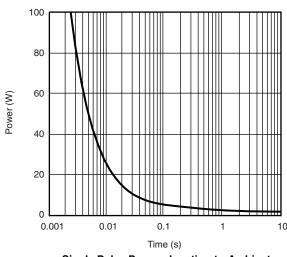


0.10 0.08 0.06 0.04 0.04 0.02 0.02 0.04 0.02 0.04 0.02 0.04 0.05 0.04 0.05 0.06 0.06

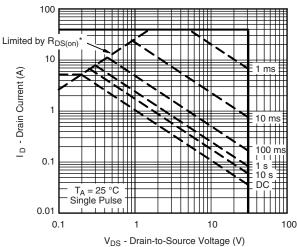
2

V<sub>GS</sub> - Gate-to-Source Voltage (V)

On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

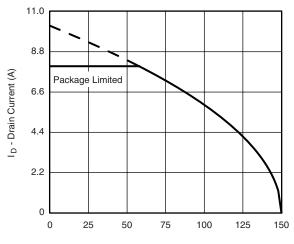


\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area

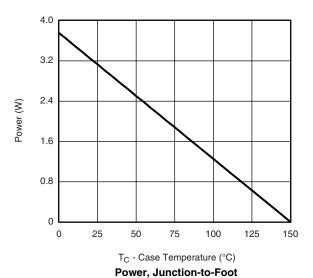
# VISHAY.

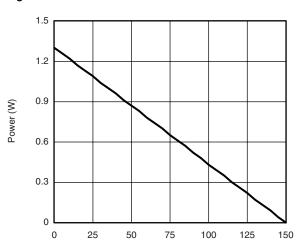
### CHANNEL-2 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



T<sub>C</sub> - Case Temperature (°C)

#### **Current Derating\***





T<sub>A</sub> - Ambient Temperature (°C)

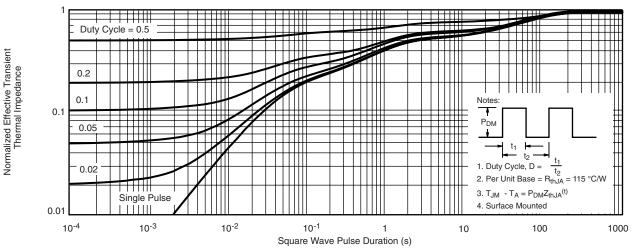
Power, Junction-to-Ambient

\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

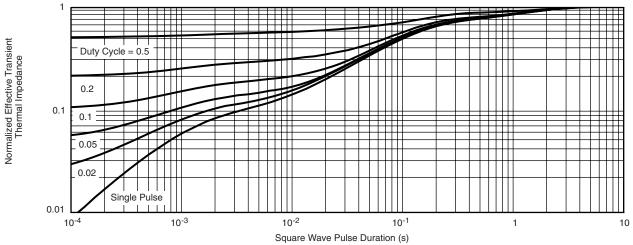
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#### CHANNEL-2 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient

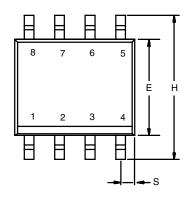


Normalized Thermal Transient Impedance, Junction-to-Foot

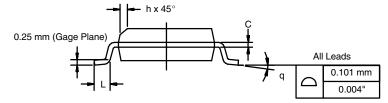
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Document Number: 69654 S09-2109-Rev. E, 12-Oct-09

SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	INCHES				
DIM	Min	Max	Min	Max			
Α	1.35	1.75	0.053	0.069			
A <sub>1</sub>	0.10	0.20	0.004	0.008			
В	0.35	0.51	0.014	0.020			
С	0.19	0.25	0.0075	0.010			
D	4.80	5.00	0.189	0.196			
Е	3.80	4.00	0.150	0.157			
е	1.27	BSC	0.050 BSC				
Н	5.80	6.20	0.228	0.244			
h	0.25	0.50	0.010	0.020			
L	0.50	0.93	0.020	0.037			
q	0°	8°	0°	8°			
S	0.44	0.64	0.018	0.026			
ECN: C-06527-Rev. I. 11-Sep-06							

DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06



#### **RECOMMENDED MINIMUM PADS FOR SO-8**



Recommended Minimum Pads Dimensions in Inches/(mm)

Return to Index

APPLICATION NOT

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